



N-Channel 100 V (D-S) MOSFET

PRODUC	CT SUMMARY		
V _{DS} (V)	$R_{DS(on)}(\Omega)$ (Max.)	I _D (A) ^f	Q _g (Typ.)
	0.0210 at V _{GS} = 10 V	36.5	
100	0.0230 at V _{GS} = 7.5 V	35	10 nC
	0.0260 at V _{GS} = 6 V	32	

PowerPAK 1212-8S 3.3 mm Bottom View

Ordering Information: SiSS40DN-T1-GE3 (Lead (Pb)-free and Halogen-free)

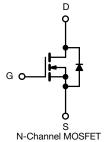
FEATURES

- ThunderFET® Technology Optimizes Balance of $R_{DS(on)}$, Q_g , Q_{sw} and Q_{oss} 100 % R_g and UIS Tested
- Material categorization: For definitions of compliance please see www.vishav.com/doc?99912



APPLICATIONS

- Primary side switch
- Synchronous Rectification
- DC/DC Conversion
- Load Switching
- **Boost Converters**
- DC/AC Inverters



ABSOLUTE MAXIMUM RATIN	IGS (T _A = 25 °C	, unless oth	erwise noted)	
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V _{DS}	100	V
Gate-Source Voltage		V _{GS}	± 20	v
	T _C = 25 °C		36.5	
Continuous Drain Current (T = 150 °C)	T _C = 70 °C	1 ,	29	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	- I _D	9.7 ^{a, b}	
	T _A = 70 °C	1	7.8 ^{a, b}	A
Pulsed Drain Current (t = 300 μs)		I _{DM}	60	
Continuous Source-Drain Diode Current	T _C = 25 °C	1-	40 ^g	
Continuous Cource-Diam Diode Current	T _A = 25 °C	- I _S	3.1 ^{a, b}	
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	20	
Single Pulse Avalanche Energy	L = 0.111111	E _{AS}	20	mJ
	T _C = 25 °C		52	
Maximum Power Dissipation	T _C = 70 °C] 。	33	w
Maximum Fower Dissipation	T _A = 25 °C	- P _D	3.7 ^{a, b}	VV
	T _A = 70 °C	1	2.4 ^{a, b}	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C
Soldering Recommendations (Peak Temperature) ^{c, d}			260	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{a, e}	t ≤ 10 s	R _{thJA}	26	33	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	1.9	2.4	C/VV

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. See solder profile (www.vishay.com/doc?73257). The PowerPAK 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- d. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- e. Maximum under steady state conditions is 81 °C/W.
- f. Based on $T_C = 25$ °C. g. Package limited.

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SiSS40DN

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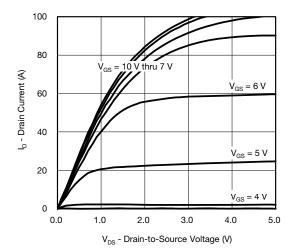
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	•				<u> </u>		
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100			V	
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J			61			
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 6.8		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	2.3		3.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
<u> </u>	400	V _{DS} = 100 V, V _{GS} = 0 V			1		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 100 V, V _{GS} = 0 V, T _J = 55 °C			10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	20			Α	
	D(OII)	V _{GS} = 10 V, I _D = 10 A		0.0176	0.0210		
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 7.5 \text{ V, } I_D = 7 \text{ A}$		0.0190	0.0230	Ω	
	20(011)	V _{GS} = 6 V, I _D = 5 A		0.0216	0.0260	-	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 10 A		25		S	
Dynamic ^b	9.0	50 5			l	l	
Input Capacitance	C _{iss}			845			
Output Capacitance	C _{oss}	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		220		pF	
Reverse Transfer Capacitance	C _{rss}	20 1 00		21.5			
·	100	V _{DS} = 50 V, V _{GS} = 10 V, I _D = 10 A		16	24		
Total Gate Charge	Qg	V _{DS} = 50 V, V _{GS} = 7.5 V, I _D = 10 A		12.2	18.5		
-		BC 40 B		10	15	nC	
Gate-Source Charge	Q _{gs}	$V_{DS} = 50 \text{ V}, V_{GS} = 6 \text{ V}, I_D = 10 \text{ A}$		3.4			
Gate-Drain Charge	Q _{gd}			4.2			
Output Charge	Q _{oss}	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$		23	35		
Gate Resistance	R_g	f = 1 MHz	0.2	0.9	1.5	Ω	
Turn-On Delay Time	t _{d(on)}			14	28		
Rise Time	t _r	V_{DD} = 50 V, R_L = 5 Ω		5	10	ns	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 6 \text{ V}, R_g = 1 \Omega$		14	28		
Fall Time	t _f	· ·		5	10		
Turn-On Delay Time	t _{d(on)}			12	24		
Rise Time	t _r	V_{DD} = 50 V, R_L = 5 Ω		5	10		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		19	38		
Fall Time	t _f			5	10		
Drain-Source Body Diode Characteristic					l	l	
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			40		
Pulse Diode Forward Current ^a	I _{SM}	-			60	A	
Body Diode Voltage	V_{SD}	I _S = 4 A, V _{GS} = 0 V		0.8	1.2	٧	
Body Diode Reverse Recovery Time	t _{rr}			39	75	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			49	95	nC	
Reverse Recovery Fall Time	t _a	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		24			
Reverse Recovery Rise Time	t _b			15		ns	

- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

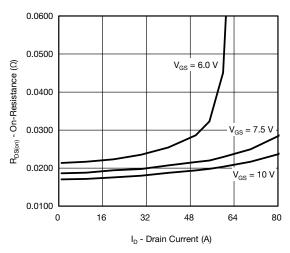
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



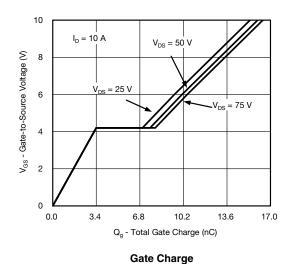
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

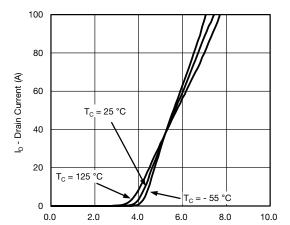


Output Characteristics

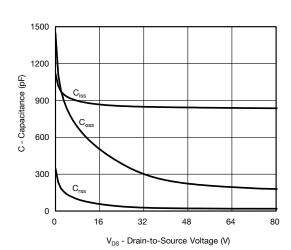


On-Resistance vs. Drain Current and Gate Voltage

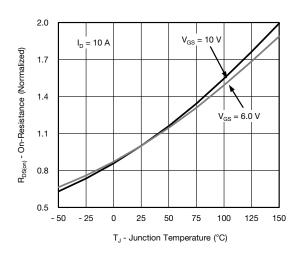




V_{GS} - Gate-to-Source Voltage (V) **Transfer Characteristics**



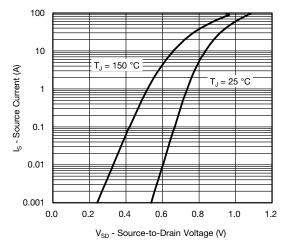
Capacitance



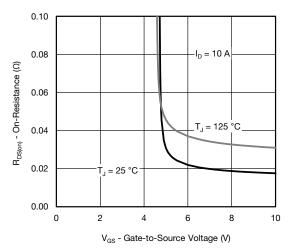
On-Resistance vs. Junction Temperature

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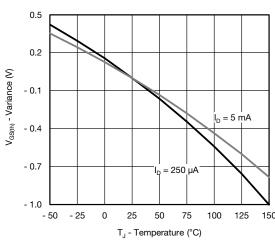
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



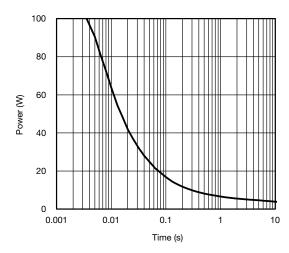
Source-Drain Diode Forward Voltage



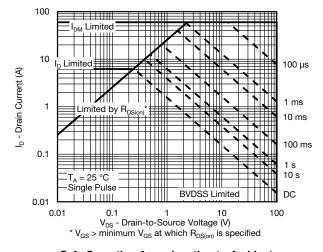
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



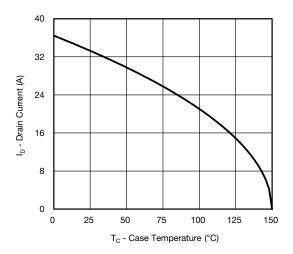
Single Pulse Power, Junction-to-Ambient



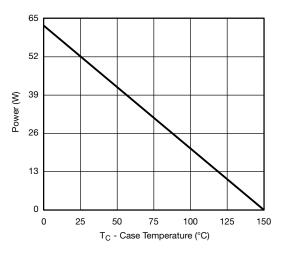
Safe Operating Area, Junction-to-Ambient



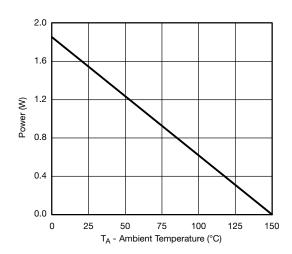
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*





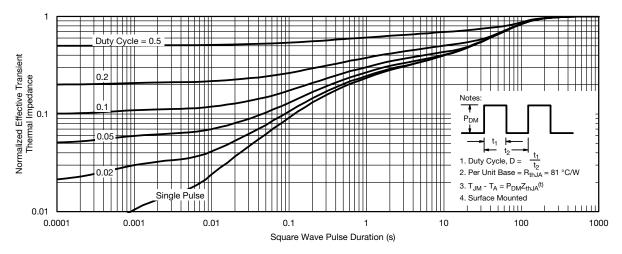


Power, Junction-to-Ambient

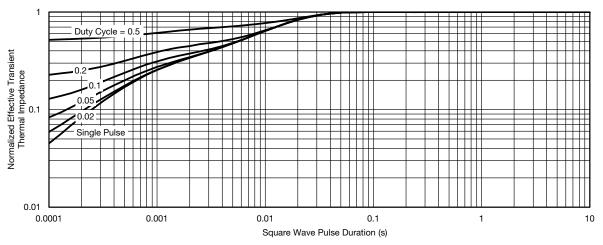
 $^{^{\}star}$ The power dissipation P_D is based on $T_{J(max.)}$ = 150 $^{\circ}$ C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heats inking is used. It is used to determine the current rating, when this rating falls below the package limit.

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient

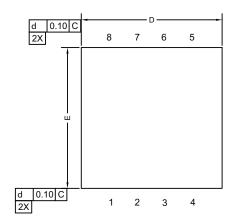


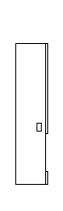
Normalized Thermal Transient Impedance, Junction-to-Case

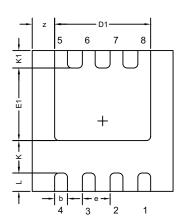
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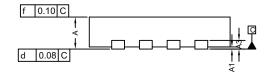


Case Outline for PowerPAK® 1212-8S









DIM.	MILLIMETERS			INCHES			
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.67	0.75	0.83	0.027	0.030	0.033	
A1	0	-	0.05	0	-	0.002	
A3		0.20 REF			0.008 REF		
b	0.30 BSC			0.012 BSC			
D	3.30 BSC			0.130 BSC			
D1	2.15	2.25	2.35	0.084	0.088	0.092	
Е		3.30 BSC		0.130 BSC			
E1	1.60	1.70	1.80	0.063	0.067	0.071	
е	0.65 BSC			0.026 BSC			
K	0.76 TYP			0.030 TYP			
K1	0.41 TYP			0.016 TYP			
L	0.43 BSC			0.017 BSC			
Z	0.525 TYP		0.021 TYP				

Note

• Millimeters will govern.

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